Efficient Conditional Reliability Updating with Sequential Importance Sampling

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Data on the performance of engineering systems can and should be used to learn system parameters and update the system reliability estimate. This can be achieved in a Bayesian framework. In order to capture the dependence of the reliability estimate on the data used, we consider the probability of failure conditional on the updating variables, i.e. those variables on which data is available. Thus, the probability of failure becomes a random variable itself. To address this challenge, we devise a procedure for the fast re-computation of failure probabilities within a sequential sampling method. We exploit the similarity of reliability problems with small distance in a suitable norm by sequentially initializing computations with failure samples of similar problem solutions.

1 Conditional probability of failure

Consider a deterministic model $Y$ with random vector input $\Theta$ that have joint distribution $\pi_\Theta$, i.e. $\forall j$, $\Theta_j \sim \pi_\Theta$. We define acceptable system behaviour in terms of the model output by using a limit-state function (LSF) $g(Y)$. By convention, $\tilde{g} \leq 0$ indicates system failure. Reliability analysis is concerned with estimating the probability of the failure event $F = \{\Theta : g(\Theta) \leq 0\}$, where $g = \tilde{g} \circ Y$.

$$P(F) = \int_{\Omega_\Theta} I(g(\theta) \leq 0)\pi_\Theta(\theta)d\theta = E_{\pi_\Theta}[I(g(\theta) \leq 0)], \quad I(g(\theta) \leq 0) = \begin{cases} 1, & g(\theta) \leq 0 \\ 0, & \text{else} \end{cases}. \quad (1)$$

While all components of $\Theta$ are random, one can typically distinguish reducible ($\Theta_B$) and irreducible ($\Theta_A$) uncertainty in the input variables, i.e. introduce a splitting $\Theta = [\Theta_A, \Theta_B]^T$. Reducible uncertainties are subject to change through the incorporation of additional data, e.g. via Bayesian updating. The probability of failure conditional on the reducible inputs $\Theta_B$ reads [3]

$$P(\Theta_B) = P(F|\Theta_B = \theta_B) = \int_{\Omega_{\Theta_A}} I(g(\theta_B) \leq 0)\pi_{\Theta_A}(\theta_A|\theta_B)d\theta_A = E_{\pi_{\Theta_A}|\Theta_B}[I(g(\theta_B) \leq 0)|\Theta_B]. \quad (2)$$

That is, the probability of failure is a function of the outcome of the random vector $\Theta_B$ and thus a random variable itself. The distribution of $P(\Theta_B)$, $\pi_p$, can be used to quantify the influence the data used for the Bayesian updating in $\Theta_B$ has on the reliability analysis. To obtain a sampling estimate of $\pi_p$ based on $n_B$ realizations of $\Theta_B$, i.e. $\{\theta_B^j, j = 1, \ldots, n_B\}$, $n_B$ reliability problems over $\Omega_{\Theta_A}$ have to be solved:

$$P(\theta_B^j) = \int_{\Omega_{\Theta_A}} I(g(\theta_A, \theta_B^j) \leq 0)\pi_{\Theta_A}(\theta_A|\theta_B^j)d\theta_A. \quad (3)$$

2 Sequential Importance Sampling

We use sequential importance sampling (SIS, [2]) to approximate integral (3) efficiently. SIS generates samples from a sequence of distributions $\{h_i(\Theta), i = 0, \ldots, M\}$ that gradually approach the optimal importance sampling density. The distribution sequence is constructed by introducing a smooth approximation of $I(g(\theta) \leq 0)$ in the expression for the optimal importance sampling density. Once this optimal density is approached, the method estimates the probability of failure through importance sampling with the final importance sampling density $h_M$.

3 Initializing SIS (SIS-I)

The $I(g(\Theta_A, \Theta_B^j) \leq 0)$ belong to a family of functions parameterized by $\Theta_B$, i.e. they may be similar in shape. The idea of this contribution is to initialize the SIS algorithm for solving the $j$-th reliability problem with samples from a previously solved reliability problem rather than $\pi_{\Theta_A}$. The goal is to select an initial distribution which is closest possible to the $j$-th optimal IS density. Two selection strategies are proposed, one of which has been used in the context of reliability-based optimization [1]:

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Fig. 1: Schematic SIS solution progress for \( n_B \) reliability problems with LSFs \( g^j = g(\Theta_A, \Theta_B^j), j = 1, 2, \ldots, n_B \), (different colors).

1. **Memoryless Approach** The \( \theta^j_B \) are ordered by a \( L_2 \)-nearest-neighbor search [4] on \( \Omega_{\Theta_B} \). We then always pick \( h^{j-1}_0 = h^{j-1}_M \).

2. **Single-Point Search** [1] We store all previously used densities \( h^k_i, k < j, i \leq M_k \) along with the locations of their maxima \( \tilde{\theta}^k_i = \arg \min_{t \in \Omega_{\Theta}} h^k_i(t) \). Then, we pick \( i \) and \( k \) s.t. \( g^j(\tilde{\theta}^k_i) \) becomes minimal under the constraint \( g^j(\tilde{\theta}^k_i) \geq 0 \).

It is possible, that the selected density has little shared probability mass with the target density. In such case, the analysis becomes instable and is instead restarted from \( \pi_{\Theta_A} \). In future work, this shall be addressed by moving samples from the selected density to regions of higher shared probability mass with the target via bridging rather than restarting.

### 4 Numerical Example

We are testing the approach (SIS-I) with a two-dimensional truss example, which is described in [5]. For the Bayesian updating, we assume measurement noise \( \epsilon \sim N(0, \sigma_\epsilon) \) and generate a measurement via \( D = Y(\mu_{\Theta_A}, \theta^{\text{true}}_B) + 2\epsilon \). The likelihood and LSF definitions read

\[
L(\theta_B) \sim \exp \left\{ -\frac{1}{2} \left( \frac{Y(\mu_{\Theta_A}, \theta_B) - D}{\sigma_\epsilon} \right)^2 \right\}, \quad g = Y(\Theta) - Y_{\text{crit}}, \quad Y_{\text{crit}} = Y(1.5\mu_{\Theta_A}, \mu_{\Theta_B}).
\]

Reference solutions are computed via performing SIS from \( \pi_{\Theta_A} \) at each sample.

Fig. 2: Prior & Posterior \(-\ln P\)-densities and respective accumulated number of limit-state function evaluations.

### 5 Conclusions

We proposed an initialization scheme for solving a sequence of reliability problems with SIS which yields a reduction in computational cost by approximately 15% (posterior) to 30% (prior) at good accuracy. The computational gains are expected to increase significantly with replacing the analysis restarting by a bridging scheme.

### References